DATA SHEET



MOS FIELD EFFECT TRANSISTOR **2SJ687**

SWITCHING **P-CHANNEL POWER MOSFET**

DESCRIPTION

The 2SJ687 is P-channel MOSFET device and a excellent switch that can be driven by a low power-supply voltage.

FEATURES

· Low on-state resistance

 $R_{DS(on)1} = 7.0 \text{ m}\Omega \text{ MAX}. \text{ (V}_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A})$

 $R_{DS(on)2} = 9.0 \text{ m}\Omega \text{ MAX}. \text{ (V}_{GS} = -3.0 \text{ V}, I_{D} = -10 \text{ A)}$

 $R_{DS(on)3} = 20 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -2.5 \text{ V, Ip} = -10 \text{ A)}$

- 2.5 V drive available
- Avalanche capability ratings

ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE	
2SJ687-ZK-E1-AY Note	D O. (Tin)	T 0500 -/	TO-252 (MP-3ZK) 0.27 g TYP.	
2SJ687-ZK-E2-AY Note	Pure Sn (Tin)	Tape 2500 p/reel		

Note Pb-free (This product does not contain Pb in external electrode.)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	-20	V
Gate to Source Voltage (V _{DS} = 0 V)	Vgss	∓12	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	∓20	Α
Drain Current (pulse) Note1	D(pulse)	∓60	Α
Total Power Dissipation (Tc = 25°C)	P _{T1}	36	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	-20	Α
Single Avalanche Energy Note2	Eas	40	mJ

(TO-252)



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = -10 V, R_G = 25 Ω , V_{GS} = $-12 \rightarrow 0$ V

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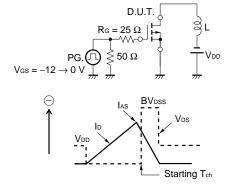
<R> <R>

ELECTRICAL CHARACTERISTICS (TA = 25°C)

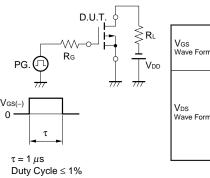
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -20 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	V _{GS} = ∓12 V, V _{DS} = 0 V			∓100	nA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-0.6	-1.2	-1.45	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = -10 V, I _D = -10 A	20			S
Drain to Source On-state Resistance Note	R _{DS(on)1}	V _{GS} = -4.5 V, I _D = -10 A		5.4	7.0	mΩ
	R _{DS(on)2}	V _{GS} = -3.0 V, I _D = -10 A		7.1	9.0	mΩ
	R _{DS(on)3}	V _{GS} = -2.5 V, I _D = -10 A		10.8	20	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		4400		pF
Output Capacitance	Coss	V _{GS} = 0 V,		1070		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		760		pF
Turn-on Delay Time	t _{d(on)}	$V_{DD} = -10 \text{ V}, I_D = -10 \text{ A},$		36		ns
Rise Time	tr	V _{GS} = -4.5 V,		220		ns
Turn-off Delay Time	t _{d(off)}	R _G = 3 Ω		270		ns
Fall Time	tr			310		ns
Total Gate Charge	Q _G	$V_{DD} = -16 V$,		57		nC
Gate to Source Charge	Qgs	V _{GS} = -4.5 V,		12		nC
Gate to Drain Charge	Q _{GD}	I _D = -20 A		28		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = -20 A, V _{GS} = 0 V		0.85	1.5	V
Reverse Recovery Time	trr	I _F = -20 A, V _{GS} = 0 V,		200		ns
Reverse Recovery Charge	Qrr	di/dt = -100 A/μs		240		nC

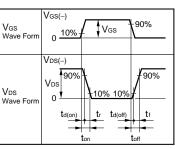
Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 2 SWITCHING TIME





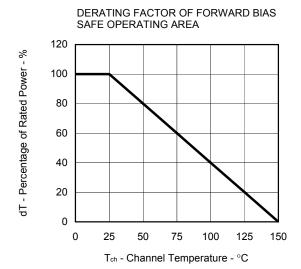
TEST CIRCUIT 3 GATE CHARGE

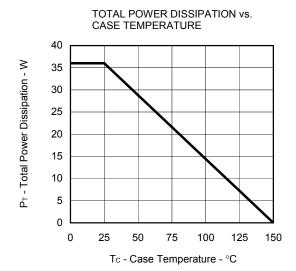
$$\begin{array}{c|c} D.U.T. \\ \hline \\ IG = -2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array} \begin{array}{c} RL \\ \hline \\ VDD \\ \end{array}$$

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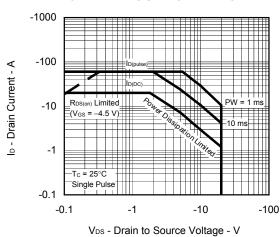
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TYPICAL CHARACTERISTICS (TA = 25°C)

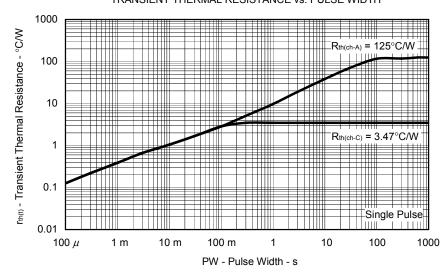




FORWARD BIAS SAFE OPERATING AREA



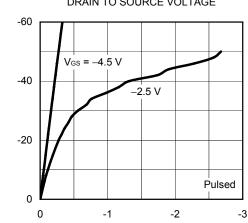
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



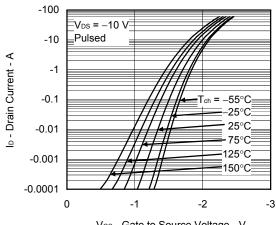
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Ip - Drain Current - A





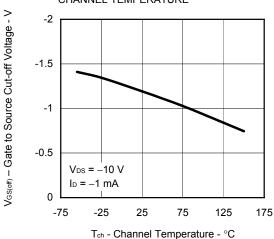
FORWARD TRANSFER CHARACTERISTICS



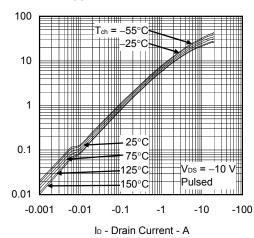
VGS - Gate to Source Voltage - V

GATE TO SOURCE CUT-OFF VOLTAGE vs. <R> CHANNEL TEMPERATURE

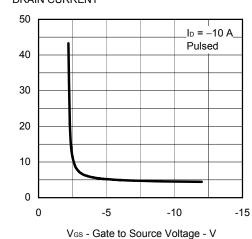
V_{DS} - Drain to Source Voltage - V



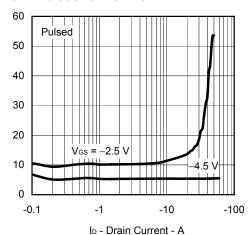
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



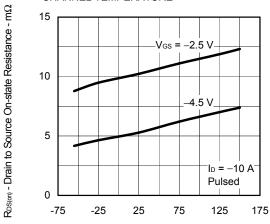
 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - Drain to Source On-state Resistance - $m\Omega$

| y₁₅ | - Forward Transfer Admittance - S

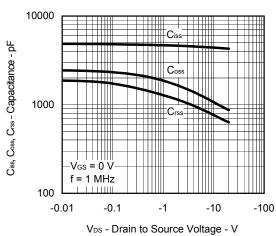
R_{DS(m)} - Drain to Source On-state Resistance - mΩ

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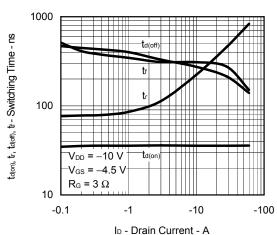


CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

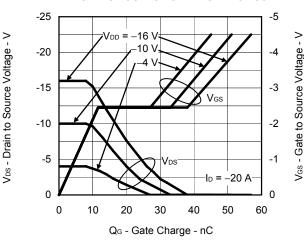


SWITCHING CHARACTERISTICS

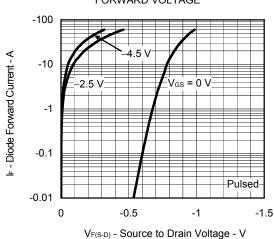
Tch - Channel Temperature - °C



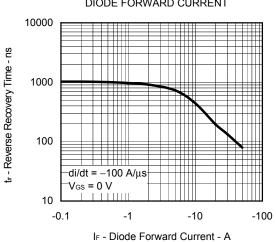
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



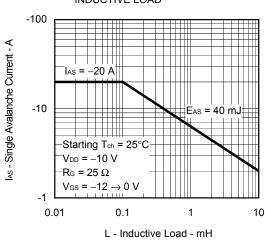
REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



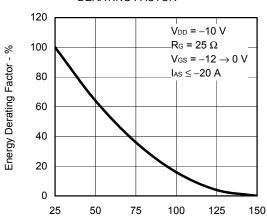
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SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY DERATING FACTOR



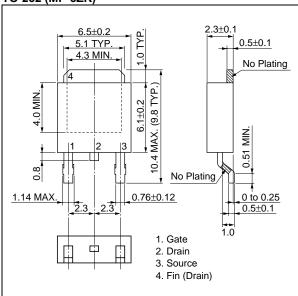
Starting T_{ch} - Starting Channel Temperature - $^{\circ}C$

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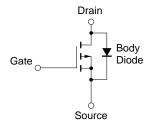
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PACKAGE DRAWING (Unit: mm)





EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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